

<b>Notice of References Cited</b>	Application/Control No. 10/679,290	Applicant(s)/Patent Under Reexamination SHISHIDO ET AL.	
	Examiner Alex Liew	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,930,308	08-2005	Lorusso et al.	250/310
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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